

Notice of References Cited	Application/Control No. 09/842,531		Applicant(s)/Patent Under Reexamination KIM, HYON T.	
	Examiner Hai V. Nguyen		Art Unit 2142	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0110125	08-2002	Banks et al.	370/392
*	B	US-7,120,128	10-2006	Banks et al.	370/254
*	C	US-7,039,922	05-2006	Shah et al.	719/326
*	D	US-7,039,046	05-2006	Simons et al.	370/388
*	E	US-6,895,453	05-2005	Allen et al.	710/33
*	F	US-6,889,380	05-2005	Shah, Rajesh R.	719/327
*	G	US-6,738,818	05-2004	Shah, Rajesh R.	709/228
*	H	US-6,715,098	03-2004	Chen et al.	714/3
*	I	US-6,711,632	03-2004	Chow et al.	710/29
*	J	US-6,694,392	02-2004	Haren, Ken C.	710/65
*	K	US-6,694,361	02-2004	Shah et al.	709/222
*	L	US-6,005,864	12-1999	Krause, Jeffrey	370/395.53
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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